

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,455	RAOULT, DIDIER M	
Examiner	Art Unit	
la-Na Hines	1645	

SEARCHED					
Class	Subclass	Date	Examiner		
435	4, 7.1, 7.2, 7.32, 7.33, 7.92	12/1/2007	JAH		
	7.94 7.95				
	35				
436	501, 512				
	513, 536				
	538, 540				
	544, 546				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	DATE	EXMR
commerical database search, derwent, medline, dissert., caplus, eplus, japio,west, biosis, toxlit, argicola, scissearch	12/18/2007	JAH
inventor search, searched related applicaations,		
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